

General Description

The AGM425MD combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

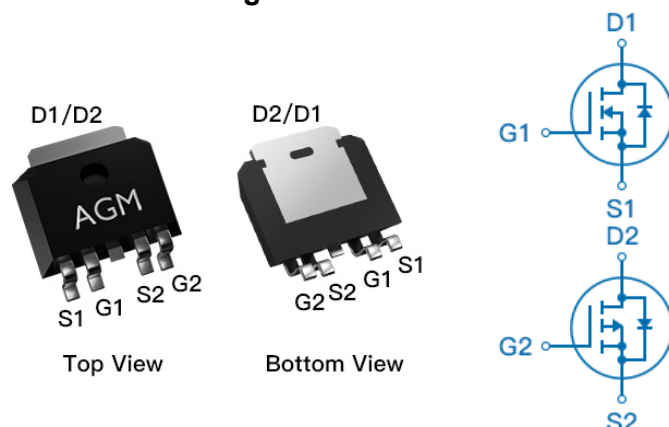
Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
40V	15mΩ	23A
-40V	32mΩ	-20A

TO-252-4L Pin Configuration



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM425MD	AGM425MD	TO-252-4L	330mm	16mm	2500

Table 1. Absolute Maximum Ratings (TA=25°C)

Symbol	Parameter	Rating		Units
		N-Ch	P-Ch	
V_{DS}	Drain-Source Voltage ($V_{GS}=0V$)	40	-40	V
V_{GS}	Gate-Source Voltage ($V_{DS}=0V$)	±20	±20	V
I_D	Drain Current-Continuous($T_c=25^{\circ}C$) (Note 1)	23	-20	A
	Drain Current-Continuous($T_c=100^{\circ}C$)	18	-12.6	A
IDM (pluse)	Drain Current-Pulsed (Note 2)	92	-80	A
P_D	Total Power Dissipation($T_c=25^{\circ}C$)	25	27.8	W
	Total Power Dissipation($T_c=100^{\circ}C$)	10	11	W
EAS	Avalanche energy (Note 3)	30	42	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient (Steady State) ¹	---	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	---	5.0	°C/W

Table 3. N- Channel Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250μA	40	--	--	V
IDSS	Zero Gate Voltage Drain Current	VDS=40V,VGS=0V	--	--	1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250μA	1.2	1.4	2.2	V
gFS	Forward Transconductance	VDS=5V,ID=10A	--	12	--	S
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=15A	--	15	25	mΩ
		VGS=4.5V, ID=10A	--	22	35	mΩ
Dynamic Characteristics						
Ciss	Input Capacitance	VDS=20V,VGS=0V, F=1MHZ	--	715	--	pF
Coss	Output Capacitance		--	65	--	pF
Crss	Reverse Transfer Capacitance		--	53	--	pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz	--	2.1	--	Ω
Switching Times						
td(on)	Turn-on Delay Time	VGS=10V,VDS=20V, ID=1A,RGEN=3.3Ω	--	8.9	--	nS
tr	Turn-on Rise Time		--	2.2	--	nS
td(off)	Turn-Off Delay Time		--	41	--	nS
tf	Turn-Off Fall Time		--	2.7	--	nS
Qg	Total Gate Charge	VGS=4.5V, VDS=12V, ID=20A	--	5.5	--	nC
Qgs	Gate-Source Charge		--	1.25	--	nC
Qgd	Gate-Drain Charge		--	2.5	--	nC
Source-Drain Diode Characteristics						
ISD	Source-Drain Current(Body Diode)		--	--	23	A
VSD	Forward on Voltage	VGS=0V,IS=15A	--	--	1.2	V
trr	Reverse Recovery Time	IF=15A , dI/dt=100A/μs , TJ=25℃	--	--	--	ns
Qrr	Reverse Recovery Charge		--	--	--	nc

Notes 1.The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25°C, VDD=25V, Vgs=10V, ID=11A, L=0.5mH, RG=25ohm

Table 3. P-Channel Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250μA	-40	--	--	V
IDSS	Zero Gate Voltage Drain Current	VDS=-40V,VGS=0V	--	--	-1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250μA	-1.2	-1.5	-2.2	V
gFS	Forward Transconductance	VDS=-5V,ID=-10A	--	18	--	S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-15A	--	32	45	mΩ
		VGS=-4.5V, ID=-10A	--	41	52	mΩ
Dynamic Characteristics						
Ciss	Input Capacitance	VDS=-20V,VGS=0V, F=1MHZ	--	880	--	pF
Coss	Output Capacitance		--	87	--	pF
Crss	Reverse Transfer Capacitance		--	77	--	pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz	--	11	--	Ω
Switching Times						
td(on)	Turn-on Delay Time	VGS=-10V,VDS=-20V, ID=-6A,RGEN=3Ω	--	5.9	--	nS
tr	Turn-on Rise Time		--	7.1	--	nS
td(off)	Turn-Off Delay Time		--	25	--	nS
tf	Turn-Off Fall Time		--	8.2	--	nS
Qg	Total Gate Charge	VGS=-10V, VDS=-20V, ID=-6A	--	17	--	nC
Qgs	Gate-Source Charge		--	4.2	--	nC
Qgd	Gate-Drain Charge		--	3.7	--	nC
Source-Drain Diode Characteristics						
ISD	Source-Drain Current(Body Diode)		--	--	-20	A
VSD	Forward on Voltage	VGS=0V,IS=-15A	--	--	-1.2	V
trr	Reverse Recovery Time	IF=-15A , dI/dt=100A/μs , TJ=25℃	--	--	--	ns
Qrr	Reverse Recovery Charge		--	--	--	nc

Notes 1.The maximum current rating is package limited.

Notes2.Repetitive Rating: Pulse width limited by maximum junction temperature Notes

3.EAS condition: TJ=25°C, VDD=-25V, Vgs=-10V, ID=-13A, L=0.5mH, RG=25ohm

N-Channel Typical Characteristics

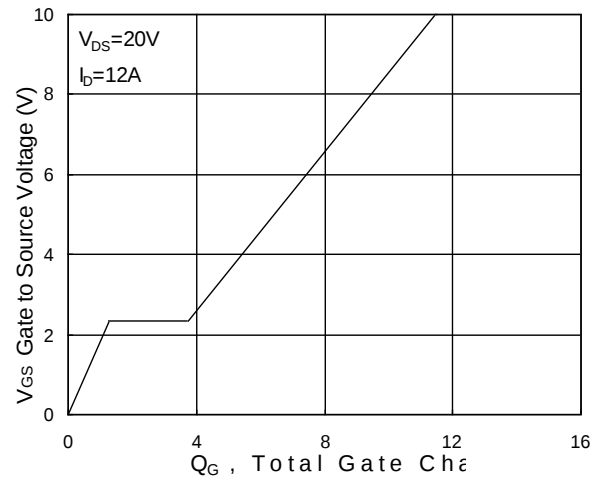
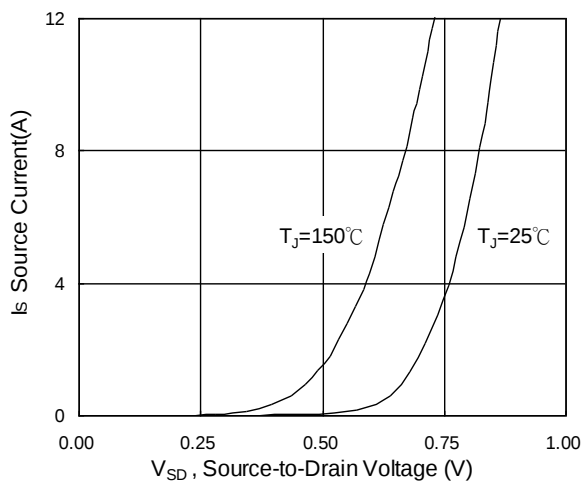
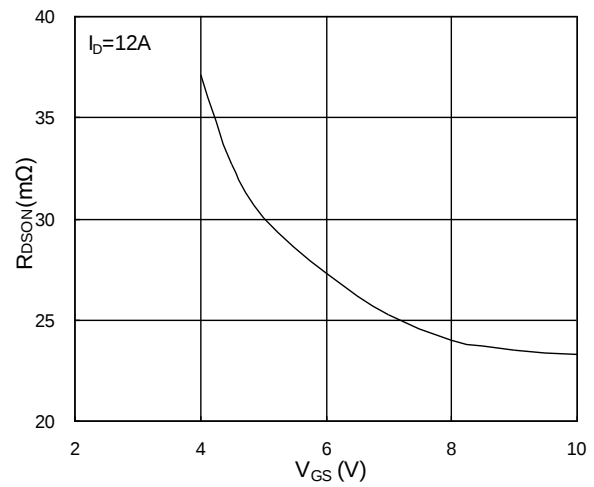
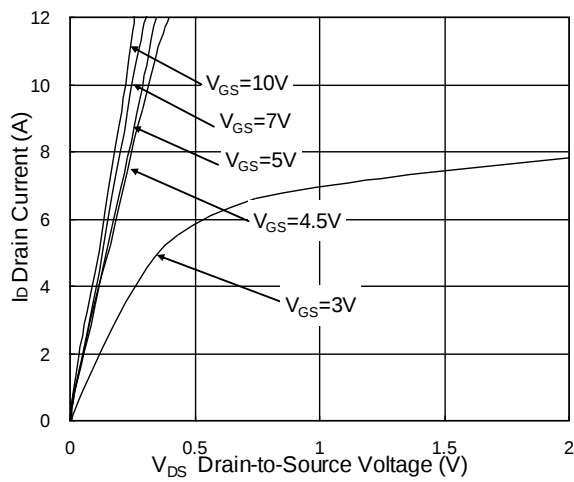


Fig 3 Forward Characteristics of Reverse

Fig 4 Gate-Charge Characteristics

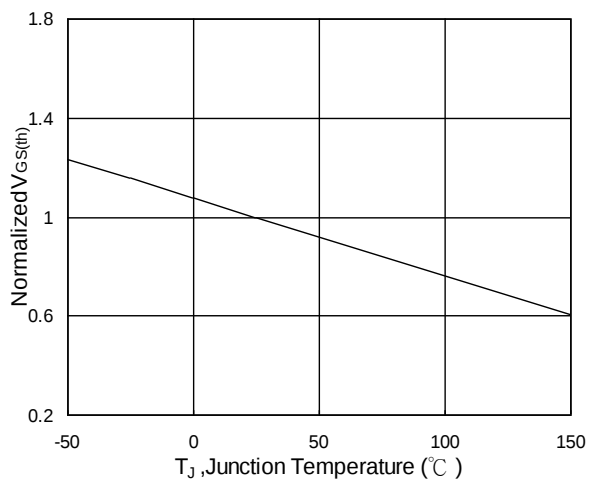


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

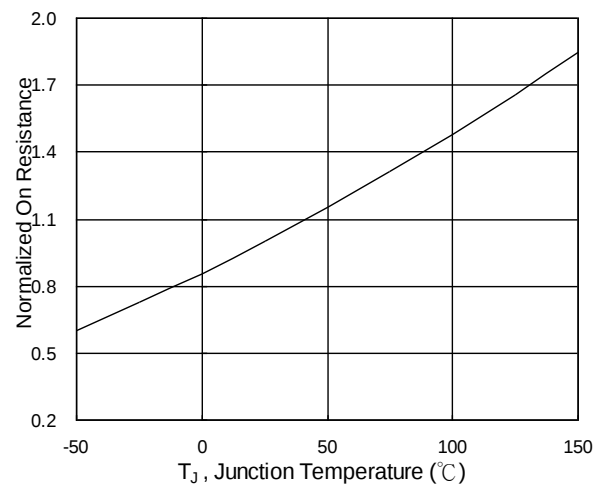


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

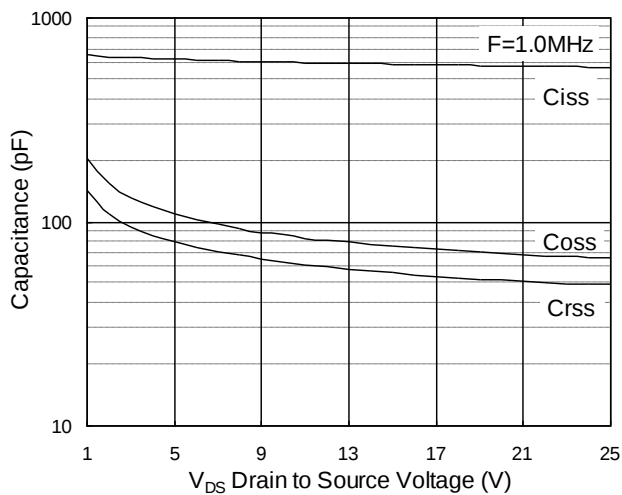


Fig.7 Capacitance

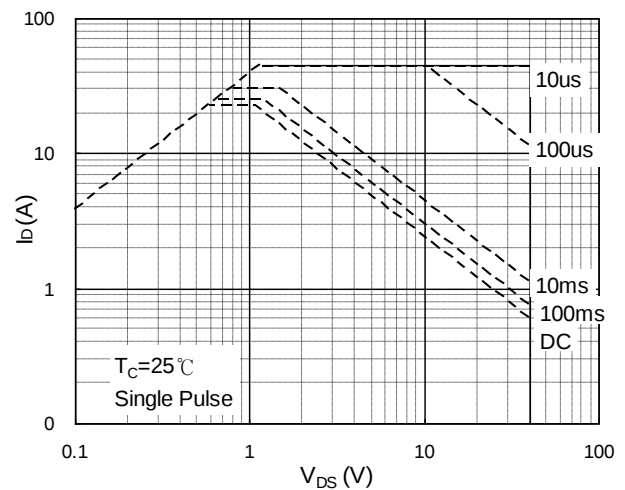


Fig.8 Safe Operating Area

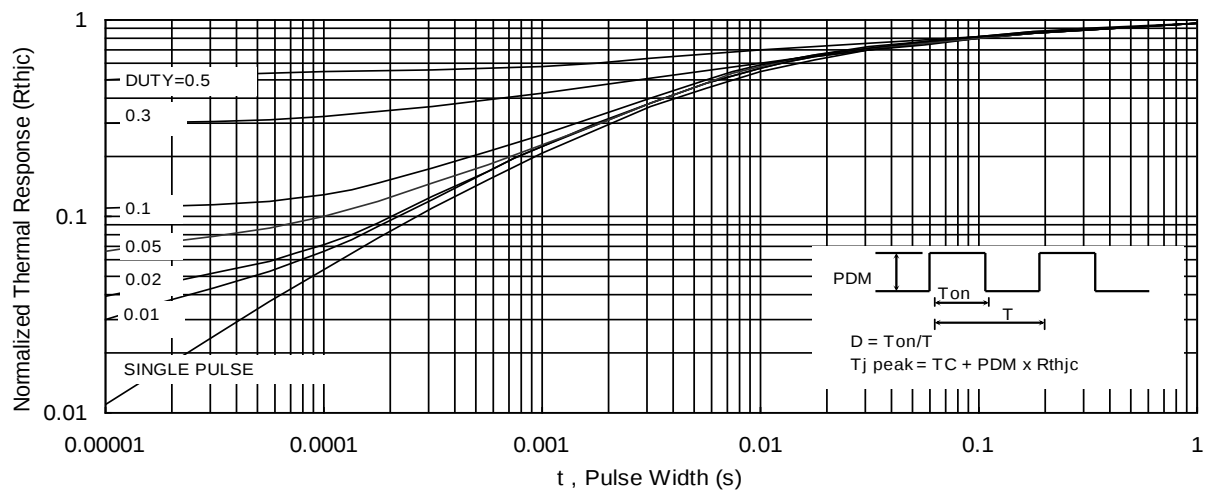


Fig.9 Normalized Maximum Transient Thermal Impedance

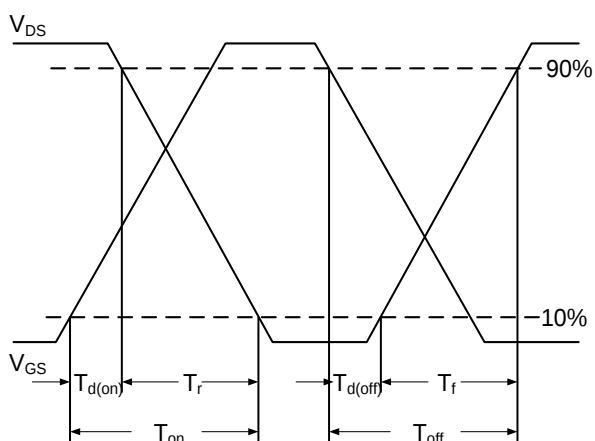


Fig.10 Switching Time Waveform

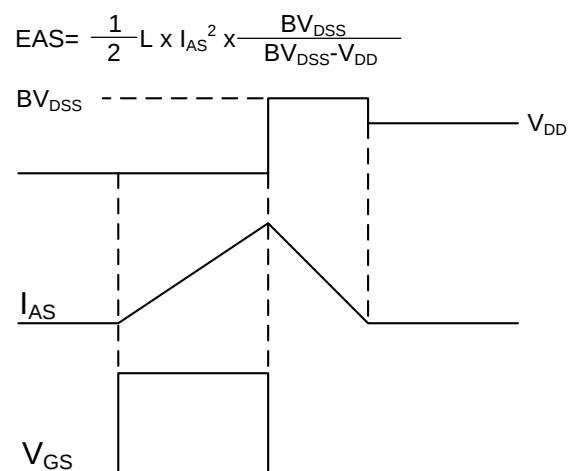


Fig.11 Unclamped Inductive Switching Wave

P-Channel Typical Characteristics

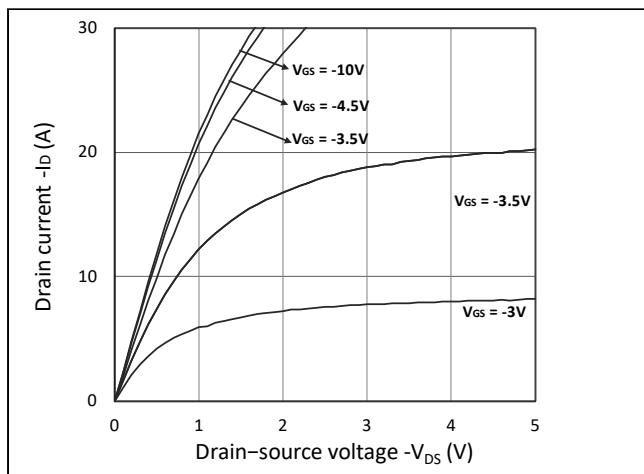


Figure 1. Output Characteristics

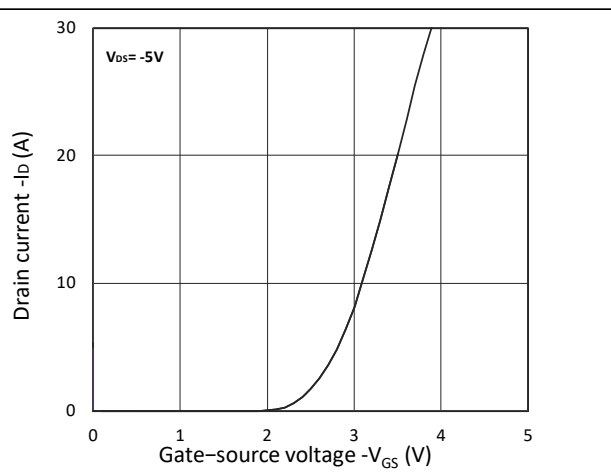


Figure 2. Transfer Characteristics

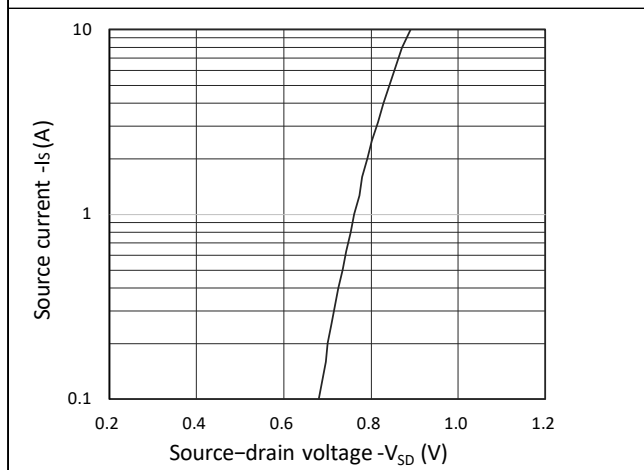
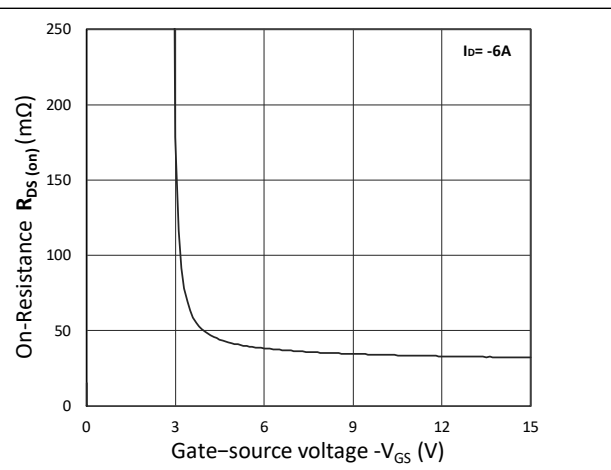
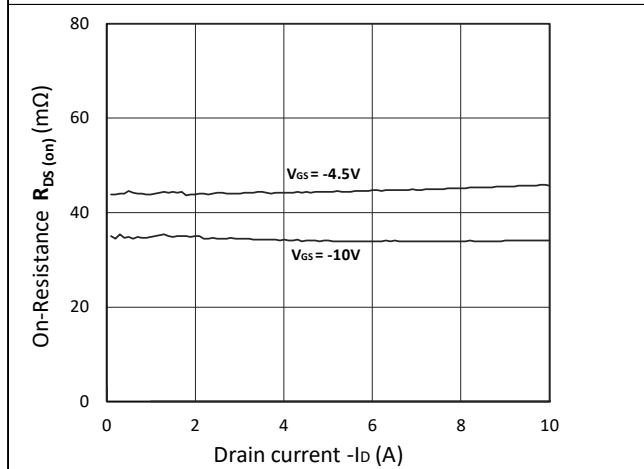
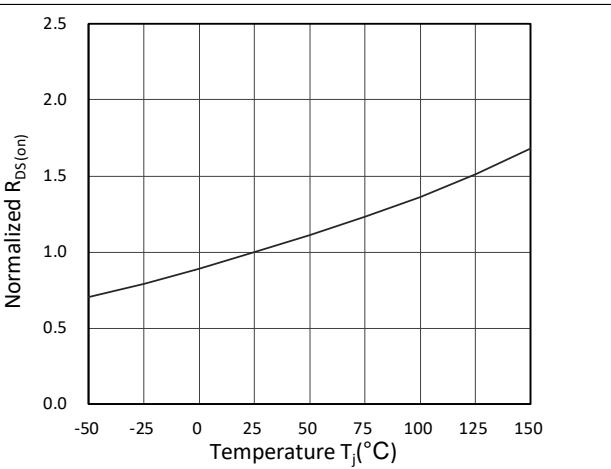


Figure 3. Forward Characteristics of Reverse


Figure 4. $R_{DS(on)}$ vs. V_{GS}

Figure 5. $R_{DS(on)}$ vs. I_D

Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

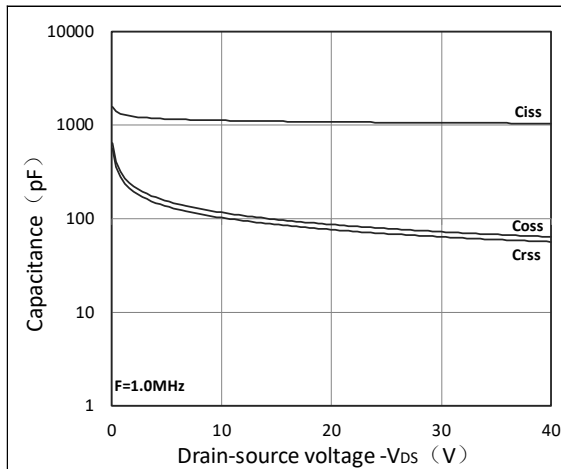


Figure 7. Capacitance Characteristics

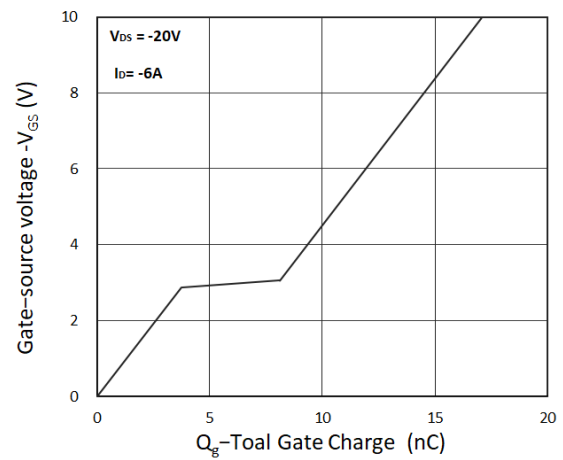


Figure 8. Gate Charge Characteristics

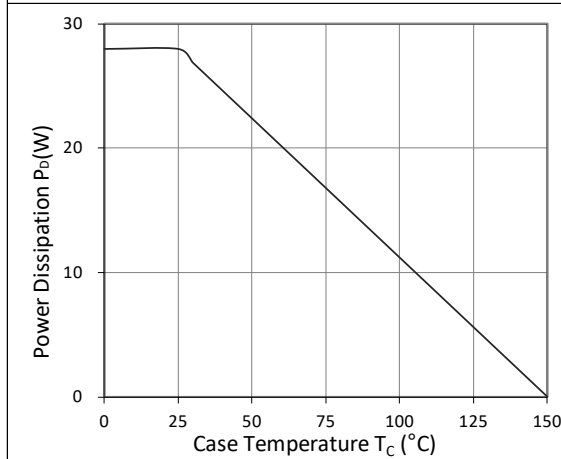


Figure 9. Power Dissipation

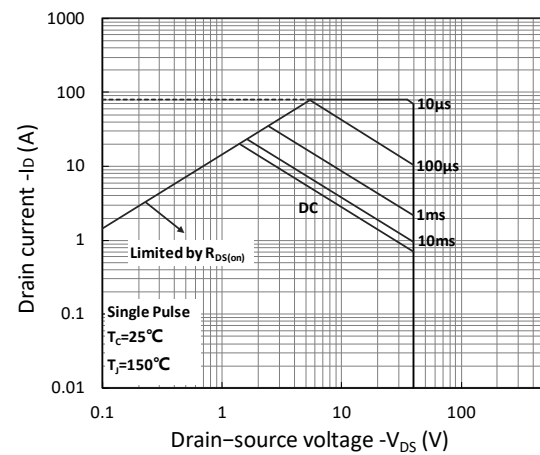


Figure 10. Safe Operating Area

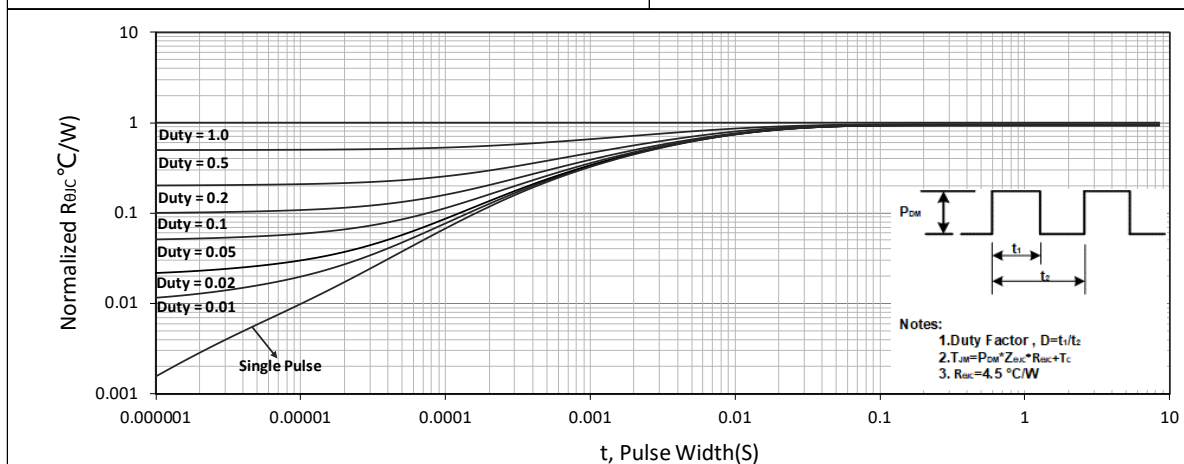


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuit

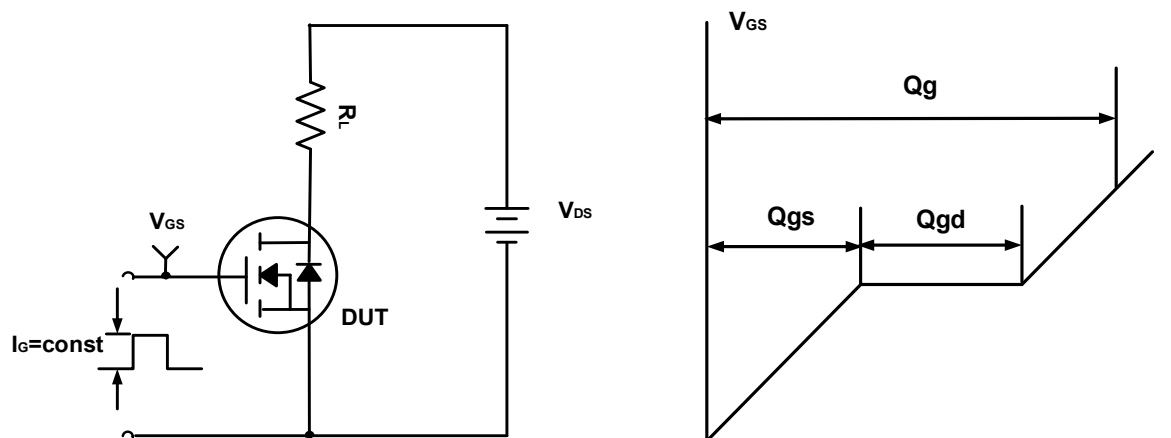


Figure A. Gate Charge Test Circuit & Waveforms

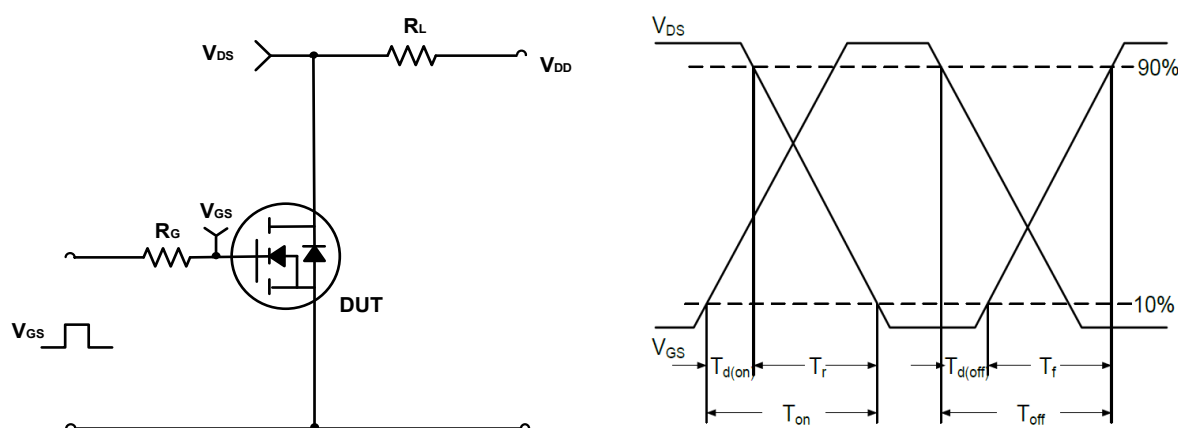


Figure B. Switching Test Circuit & Waveforms

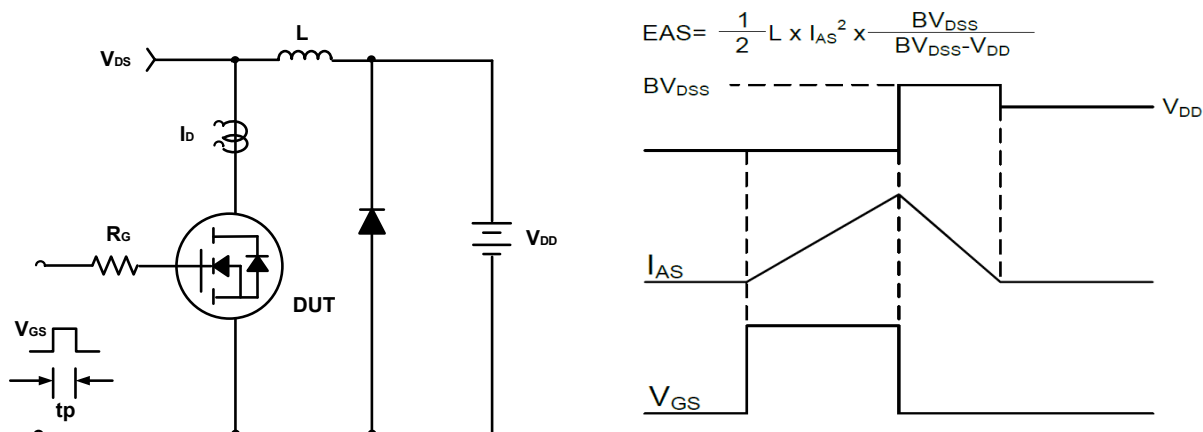
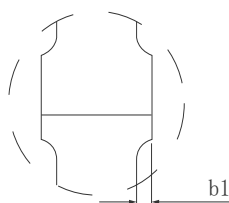
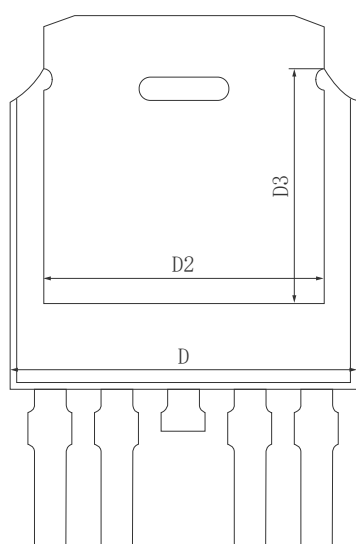
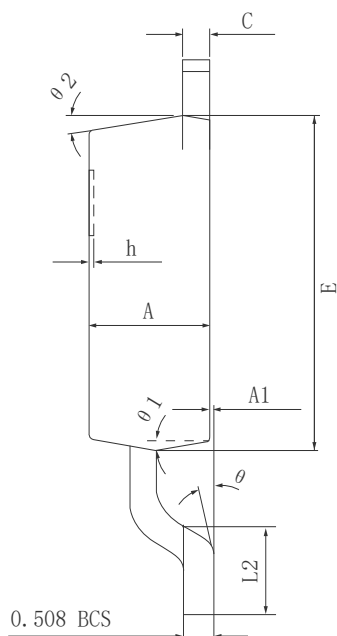
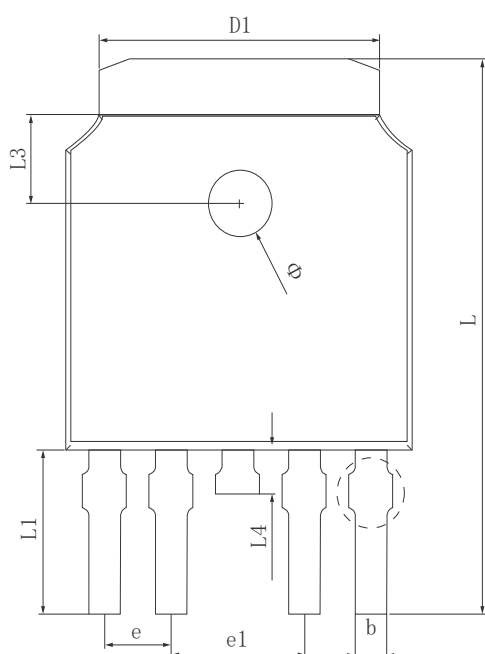


Figure C. Unclamped Inductive Switching Circuit & Waveforms

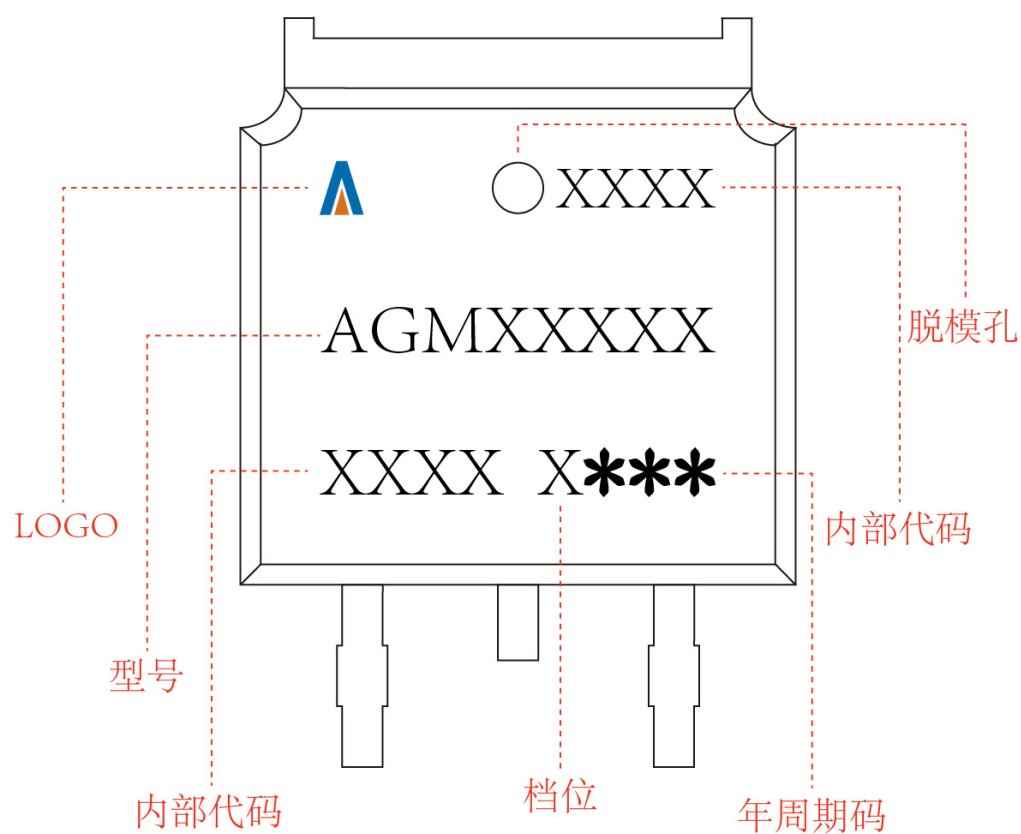
Dimensions (TO-252-4L)



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	2.200	2.300	2.400
A1	0.000		0.127
b	0.550	0.600	0.650
b1	0.000		0.120
c (电镀后)	0.460	0.520	0.580
D	6.500	6.600	6.700
D1	5.334 REF		
D2	5.346 REF		
D3	4.490 REF		
E	6.000	6.100	6.200
e	1.270 TYP		
e1	2.540 TYP		
h	0.000	0.100	0.200
L	9.900	10.100	10.300
L1	2.988 REF		
L2	1.400	1.550	1.700
L3	1.600 REF		
L4	0.700	0.800	0.900
Φ	1.100	1.200	1.300
θ	0°		8°
θ1	9° TYP		
θ2	9° TYP		

TO-252-4L

Marking Instructions:



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